LCLS-II HXU Measurement Results

This report is intended to document the results of HXU segment tuning at LBNL and ANL. It should be sent to SLAC for approval before the HXU segment gets shipped.

Serial number from manufacturer's label:	HXU-024
--	---------

Measurement Procedure:

The measurements have been carried out after the undulator segment had been fully tuned according to "LCLS-II Undulator Test Plan" (LCLS-TN-17-1).

General Hall Probe Scan Evaluation Parameters	3	
Undulator Temperature (should be 20.0)	20.37± 0.34	°C
First core pole # (count includes zero potential pole)	8	
Last core pole # (count includes zero potential pole)	253	
Tuning Gap	8.9999	mm

Evaluation of Hall Probe Scans at Commissioning Gap

Commissioning Gap Temperature (should be 20.0)	20.30± 0.29	°C
$rms(B_{pk} /< B_{pk}) > -1)$	0.00198	-
K _{eff} at Commissioning Gap (should be 2.3400)	2.3403	
Commissioning Gap	7.8753	mm
I1X (over 4.012667 m) (should be within ±40)	-12.9	μTm
I2X (over 4.012667 m) (should be within ±150)	69	μTm^2
I1Y (over 4.012667 m) (should be within ±40)	24.6	μTm
12Y (over 4.012667 m) (should be within ±150)	76	μTm^2
Phase Shake (rms phase fluctuations over core poles) (<4.0)	2.241	degXray
Cell Phase Advance (over 4.012667 m)	486,601.5 (135×360+1.53)	degXray
Undulator Entrance Phase ¹	2,250.9 (25×90+0.94)	degXray
Undulator Exit Phase ²	2,250.6 (25×90+0.59)	degXray

¹ Phase advance from cell start (undulator center – 2.006334 m) to center of physical pole 8.

² Phase advance from physical pole 253 to cell end (undulator center + 2.006334 m).

Undulator Encoder Settings

USGapEncoderOffset	-1109.3057
DSGapEncoderOffset	-823.0245
USWLinearEncoder.AOFF	90.311
DSWLinearEncoder.AOFF	92.0093
USALinearEncoder.AOFF	92.8321
DSALinearEncoder.AOFF	92.0029

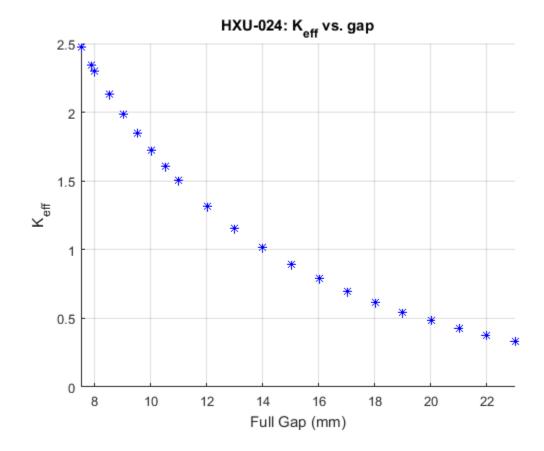
Undulator Load Cell Readings at Tuning Gap (Gap Opening)

LC_DAL_FORCE	-186.062
LC_DAU_FORCE	-321.9326
LC_DWL_FORCE	-239.5027
LC_DWU_FORCE	-239.1183
LC_UAL_FORCE	-223.0613
LC_UAU_FORCE	-278.1382
LC_UWL_FORCE	-211.039
LC_UWU_FORCE	-306.6484

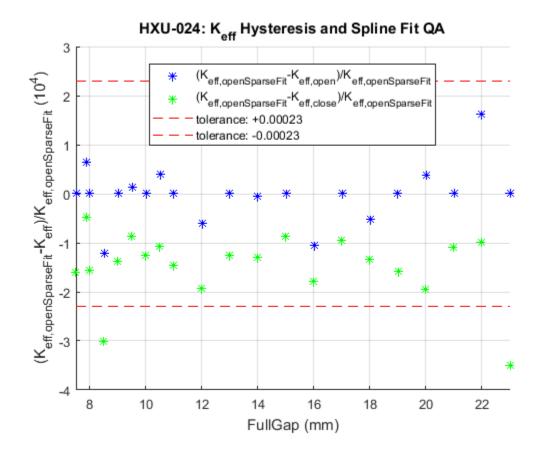
Undulator Load Cell Readings at 100 mm Gap (Gap Opening)

LC_DAL_FORCE	3.92
LC_DAU_FORCE	4.13
LC_DWL_FORCE	5.79
LC_DWU_FORCE	3.03
LC_UAL_FORCE	2.87
LC_UAU_FORCE	1.12
LC_UWL_FORCE	2.88
LC_UWU_FORCE	1.99

Evaluation of Hall Probe Scans: Keff vs gap



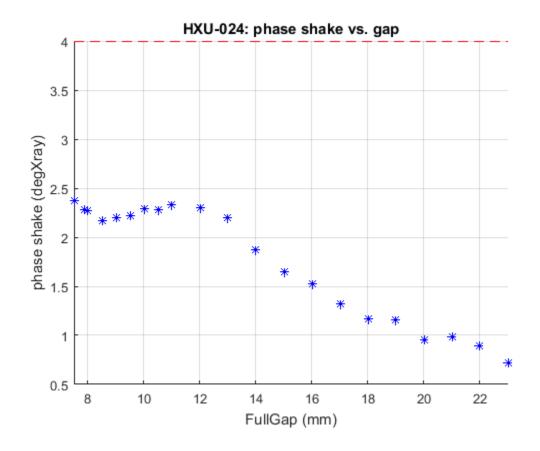
Evaluation of Hall Probe Scans: Keff Hysteresis using Half Gap Encoders



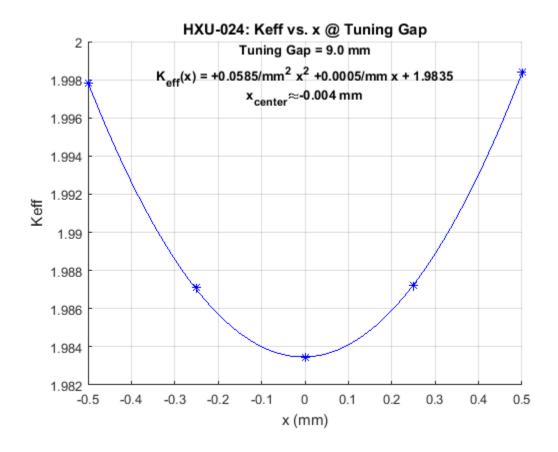
Plotted functions have been calculated from measured values openKeff (opengap) and closeKeff (closegap) using the following Matlab calculations:

Blue Stars: 1-openKeff./spline(opengap(1:2:end),openKeff(1:2:end),opengap) Green Stars: 1-closeKeff./spline(opengap(1:2:end),openKeff(1:2:end),closegap)

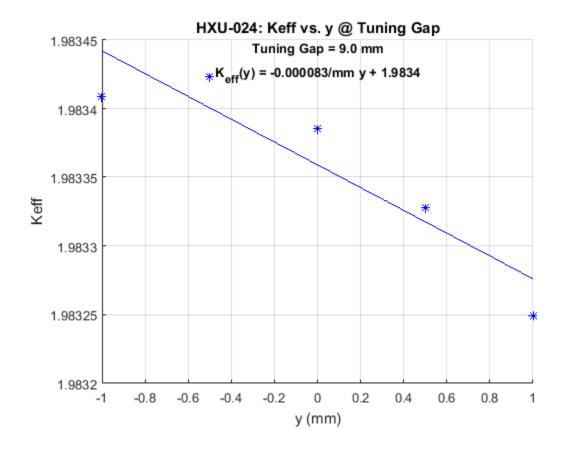
Evaluation of Hall Probe: Phase Shake vs. gap



Evaluation of Hall Probe: Keff vs x at Tuning Gap



Evaluation of Hall Probe: K_{eff} vs y at Tuning Gap

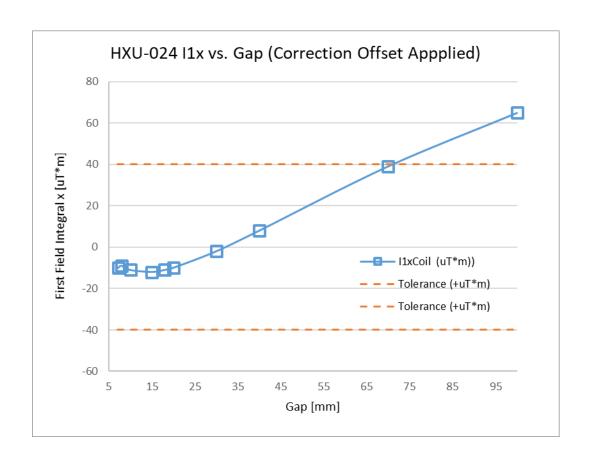


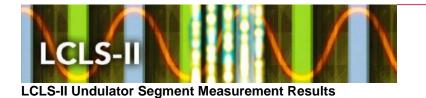


LCLS-II Undulator Segment Measurement Results

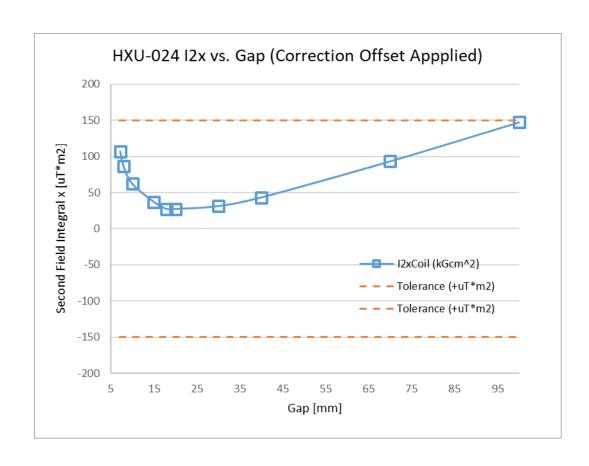
HXU-024

Long Coil Measurement of the On-Axis First Horizontal Field Integrals with +30 $\mu T \cdot m$ Integral Offset

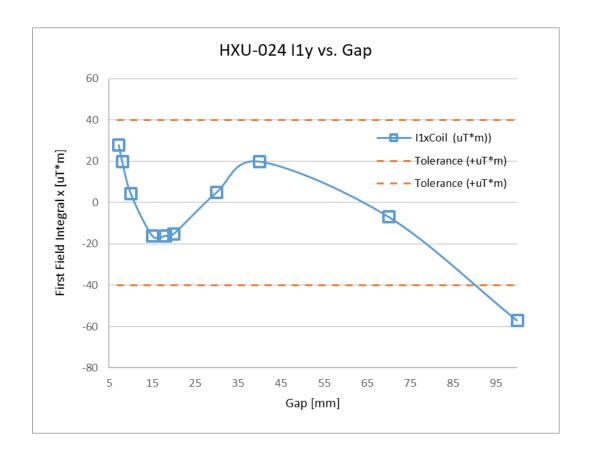


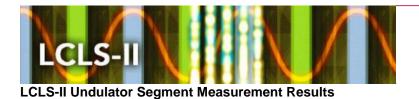


Long Coil Measurement of the On-Axis Second Horizontal Field Integrals with +30 $\mu T \cdot m~x~0.5~x~4.012667~m$ Second Integral Offset

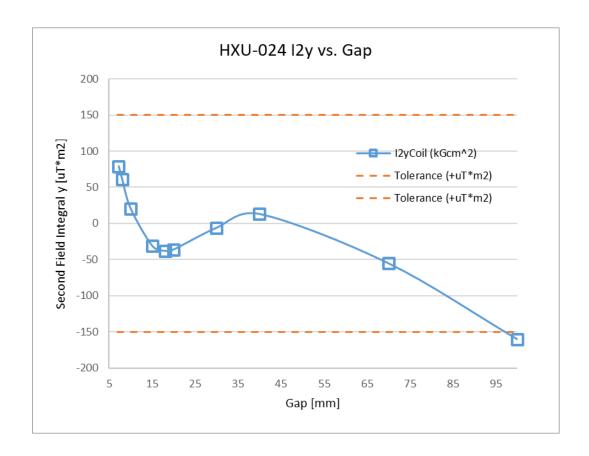


Long Coil Measurement of the On-Axis First Vertical Field Integrals

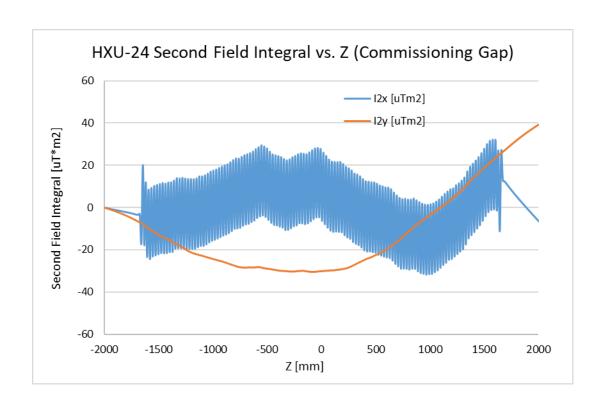




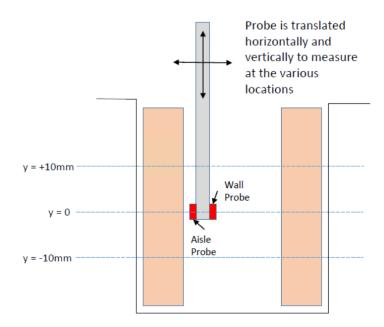
Long Coil Measurement of the On-Axis Second Vertical Field Integrals



Second Horizontal and Vertical Field Integrals along Undulator Length at Commissioning Gap

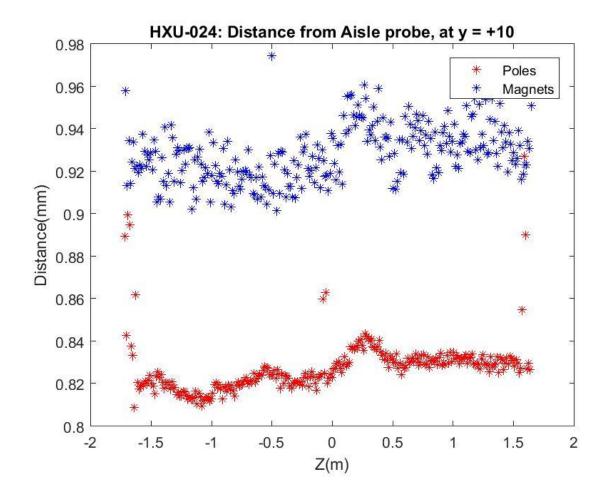


Capacitive Sensor Arrangement

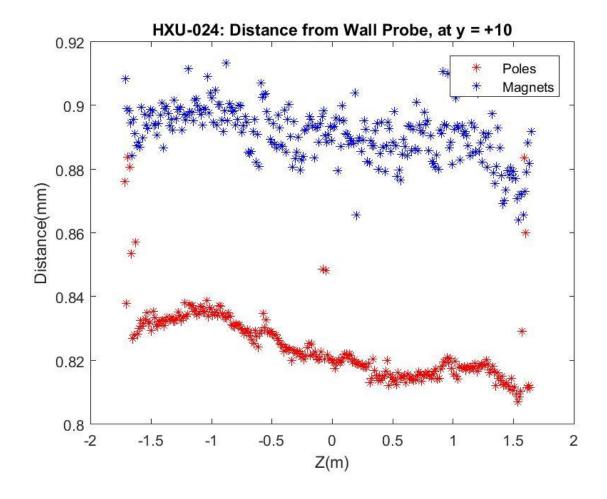


The following plots show the pole and magnet position measurements. The ANL system has two back-to-back capacitive probes on one probe holder. The x and y stages on the 6-meter bench are positioned so that the probe is in the proper location for each of the 9 scan locations. For the data analysis, the average pole position in each scan is used as reference for the plotted pole and magnet positions. Note that for all plots, the first three and last three poles of the device are omitted since the measurement is not accurate due to end efects in the capacitance probe measurement..

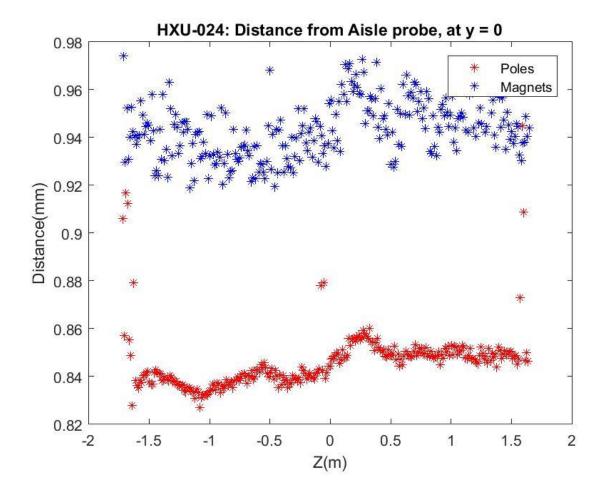
Probe 1 Capacitive Sensor Readings y = +10mm



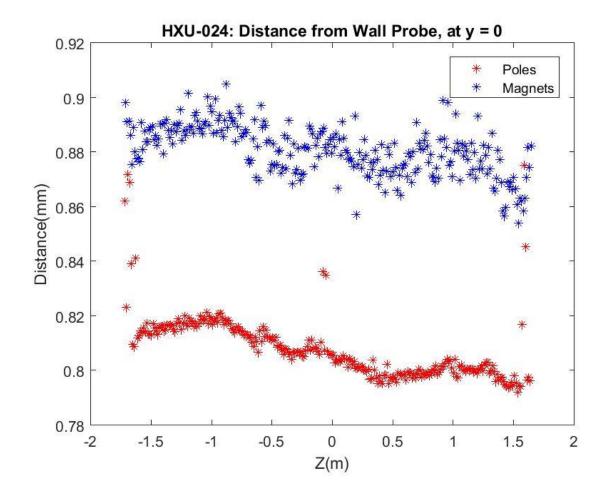
Probe2 Capacitive Sensor Readings y = +10mm



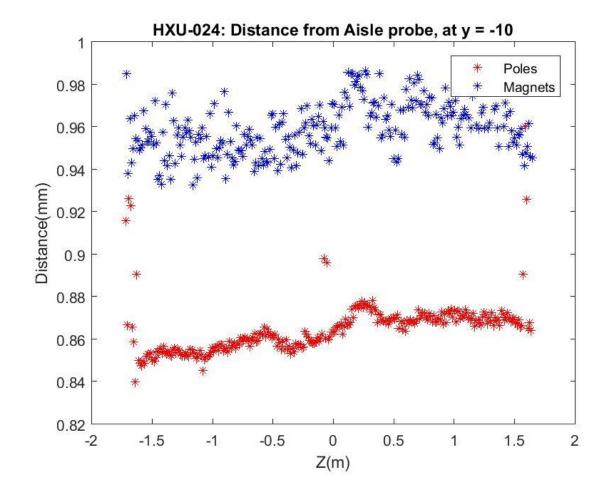
Probe1 Capacitive Sensor Readings y = 0mm



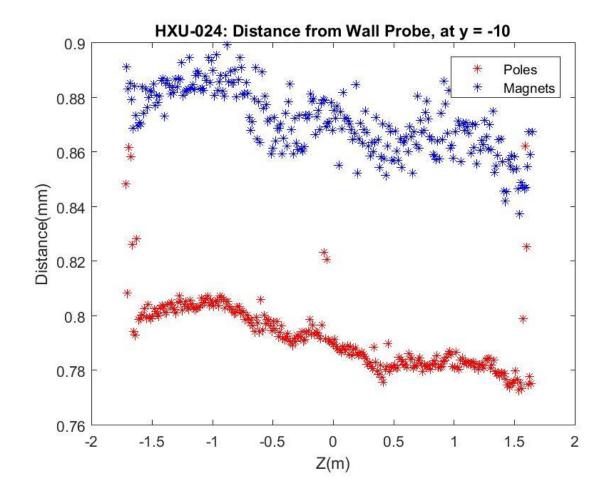
Probe2 Capacitive Sensor Readings y = 0mm



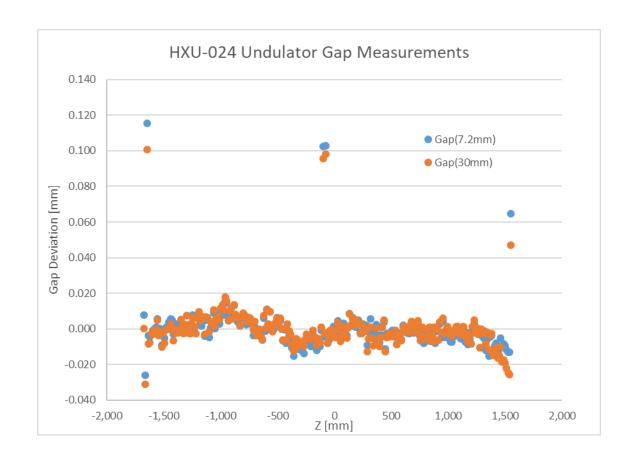
Probe1 Capacitive Sensor Readings y = -10mm



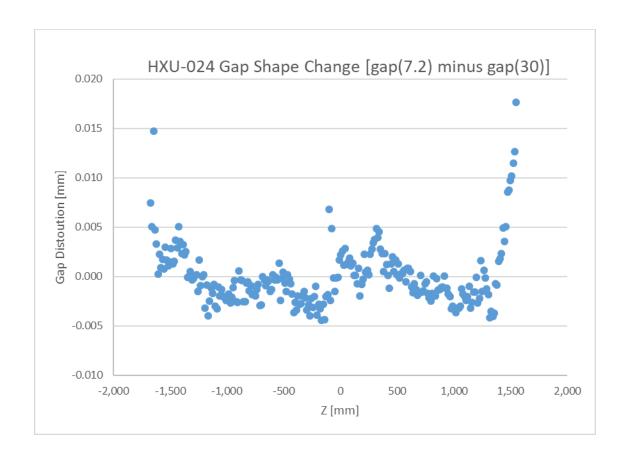
Probe2 Capacitive Sensor Readings y = -10mm



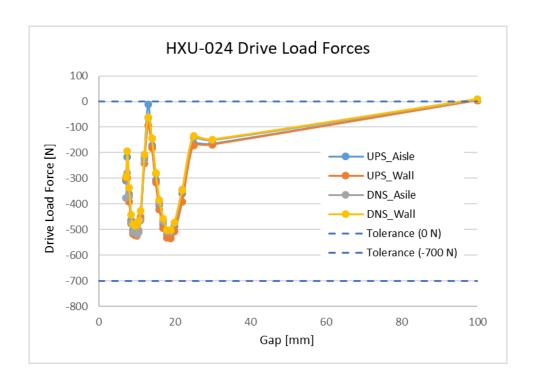
Undulator Gap Measurements



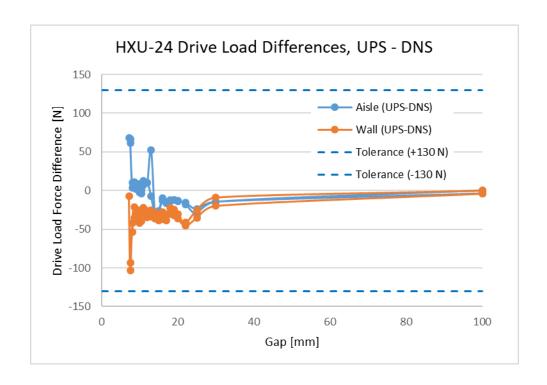
Undulator Gap Difference



Drive Loads (Gap Opening)

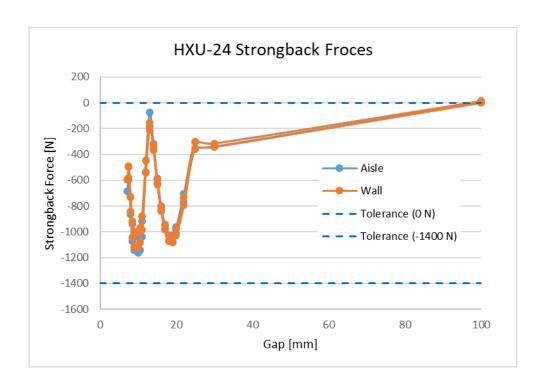


Drive Load Differences (Gap Opening - Closing)





Strongback Forces (Gap Opening and Closing)



Strongback Force Differences (Gap Closing - Opening)

